

# MOSFET

Metal Oxide Semiconductor Field Effect Transistor

## OptiMOS™

OptiMOS™3 Power-Transistor, 100 V  
BSZ440N10NS3 G

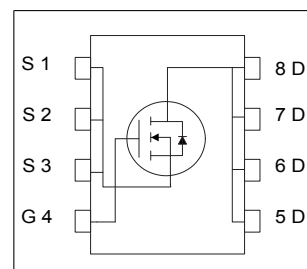
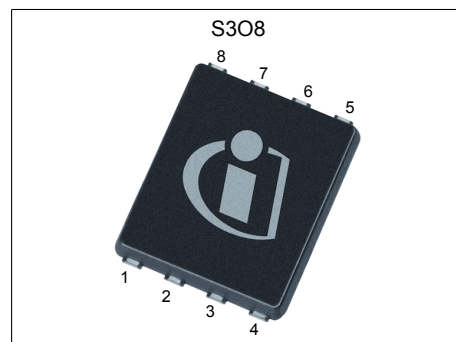
## Data Sheet

Rev. 2.1  
Final

## 1 Description

### Features

- Very low gate charge for high frequency applications
- Optimized for dc-dc conversion
- N-channel, normal level
- Excellent gate charge x  $R_{DS(on)}$  product (FOM)
- Very low on-resistance  $R_{DS(on)}$
- 150 °C operating temperature
- Pb-free lead plating; RoHS compliant
- Qualified according to JEDEC<sup>1)</sup> for target application
- Halogen-free according to IEC61249-2-21



**Table 1 Key Performance Parameters**

| Parameter        | Value | Unit |
|------------------|-------|------|
| $V_{DS}$         | 100   | V    |
| $R_{DS(on),max}$ | 44    | mΩ   |
| $I_D$            | 18    | A    |

| Type / Ordering Code | Package     | Marking | Related Links |
|----------------------|-------------|---------|---------------|
| BSZ440N10NS3 G       | PG-TSDSON-8 | 440N10N | -             |

<sup>1)</sup> J-STD20 and JESD22

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## 2 Maximum ratings

at  $T_j = 25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**  
at  $25\text{ °C}$

| Parameter                           | Symbol         | Values |      |                 | Unit | Note / Test Condition                                                                            |
|-------------------------------------|----------------|--------|------|-----------------|------|--------------------------------------------------------------------------------------------------|
|                                     |                | Min.   | Typ. | Max.            |      |                                                                                                  |
| Continuous drain current            | $I_D$          | -      | -    | 18<br>11<br>5.3 | A    | $T_C=25\text{ °C}$<br>$T_C=100\text{ °C}$<br>$T_A=25\text{ °C}$ , $R_{thJA}=50\text{ K/W}^{(1)}$ |
| Pulsed drain current <sup>(2)</sup> | $I_{D,pulse}$  | -      | -    | 72              | A    | $T_C=25\text{ °C}$                                                                               |
| Avalanche energy, single pulse      | $E_{AS}$       | -      | -    | 17              | mJ   | $I_D=12\text{ A}$ , $R_{GS}=25\text{ }\Omega$                                                    |
| Gate source voltage                 | $V_{GS}$       | -20    | -    | 20              | V    | -                                                                                                |
| Power dissipation                   | $P_{tot}$      | -      | -    | 29              | W    | $T_C=25\text{ °C}$                                                                               |
| Operating and storage temperature   | $T_j, T_{stg}$ | -55    | -    | 150             | °C   | IEC climatic category;<br>DIN IEC 68-1: 55/150/56                                                |

## 3 Thermal characteristics

**Table 3 Thermal characteristics**

| Parameter                                                                             | Symbol     | Values |      |      | Unit | Note / Test Condition |
|---------------------------------------------------------------------------------------|------------|--------|------|------|------|-----------------------|
|                                                                                       |            | Min.   | Typ. | Max. |      |                       |
| Thermal resistance, junction - case                                                   | $R_{thJC}$ | -      | -    | 4.3  | K/W  | -                     |
| Thermal resistance, junction - ambient, 6 cm <sup>2</sup> cooling area <sup>(1)</sup> | $R_{thJA}$ | -      | -    | 50   | K/W  | -                     |

<sup>1)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

<sup>2)</sup> see figure 3

## 4 Electrical characteristics

**Table 4 Static characteristics**

| Parameter                        | Symbol        | Values |            |          | Unit          | Note / Test Condition                                                                                                                                         |
|----------------------------------|---------------|--------|------------|----------|---------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------|
|                                  |               | Min.   | Typ.       | Max.     |               |                                                                                                                                                               |
| Drain-source breakdown voltage   | $V_{(BR)DSS}$ | 100    | -          | -        | V             | $V_{GS}=0\text{ V}$ , $I_D=1\text{ mA}$                                                                                                                       |
| Gate threshold voltage           | $V_{GS(th)}$  | 2      | 2.7        | 3.5      | V             | $V_{DS}=V_{GS}$ , $I_D=12\text{ }\mu\text{A}$                                                                                                                 |
| Zero gate voltage drain current  | $I_{DSS}$     | -      | 0.01<br>10 | 1<br>100 | $\mu\text{A}$ | $V_{DS}=100\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_J=25\text{ }^\circ\text{C}$<br>$V_{DS}=100\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_J=125\text{ }^\circ\text{C}$ |
| Gate-source leakage current      | $I_{GSS}$     | -      | 1          | 100      | nA            | $V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$                                                                                                                    |
| Drain-source on-state resistance | $R_{DS(on)}$  | -      | 38<br>48   | 44<br>86 | m $\Omega$    | $V_{GS}=10\text{ V}$ , $I_D=12\text{ A}$<br>$V_{GS}=6\text{ V}$ , $I_D=6\text{ A}$                                                                            |
| Gate resistance                  | $R_G$         | -      | 1.5        | -        | $\Omega$      | -                                                                                                                                                             |
| Transconductance                 | $g_{fs}$      | 8      | 15         | -        | S             | $ V_{DS} >2 I_D R_{DS(on)max}$ , $I_D=12\text{ A}$                                                                                                            |

**Table 5 Dynamic characteristics**

| Parameter                        | Symbol       | Values |      |      | Unit | Note / Test Condition                                                                       |
|----------------------------------|--------------|--------|------|------|------|---------------------------------------------------------------------------------------------|
|                                  |              | Min.   | Typ. | Max. |      |                                                                                             |
| Input capacitance <sup>1)</sup>  | $C_{iss}$    | -      | 480  | 640  | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=50\text{ V}$ , $f=1\text{ MHz}$                               |
| Output capacitance <sup>1)</sup> | $C_{oss}$    | -      | 87   | 120  | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=50\text{ V}$ , $f=1\text{ MHz}$                               |
| Reverse transfer capacitance     | $C_{rss}$    | -      | 6    | -    | pF   | $V_{GS}=0\text{ V}$ , $V_{DS}=50\text{ V}$ , $f=1\text{ MHz}$                               |
| Turn-on delay time               | $t_{d(on)}$  | -      | 4.3  | -    | ns   | $V_{DD}=50\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=6\text{ A}$ ,<br>$R_G=1.6\text{ }\Omega$ |
| Rise time                        | $t_r$        | -      | 1.8  | -    | ns   | $V_{DD}=50\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=6\text{ A}$ ,<br>$R_G=1.6\text{ }\Omega$ |
| Turn-off delay time              | $t_{d(off)}$ | -      | 9.1  | -    | ns   | $V_{DD}=50\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=6\text{ A}$ ,<br>$R_G=1.6\text{ }\Omega$ |
| Fall time                        | $t_f$        | -      | 2.0  | -    | ns   | $V_{DD}=50\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=6\text{ A}$ ,<br>$R_G=1.6\text{ }\Omega$ |

**Table 6 Gate charge characteristics<sup>2)</sup>**

| Parameter                       | Symbol        | Values |      |      | Unit | Note / Test Condition                                                      |
|---------------------------------|---------------|--------|------|------|------|----------------------------------------------------------------------------|
|                                 |               | Min.   | Typ. | Max. |      |                                                                            |
| Gate to source charge           | $Q_{gs}$      | -      | 2.2  | -    | nC   | $V_{DD}=50\text{ V}$ , $I_D=6\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate to drain charge            | $Q_{gd}$      | -      | 1.3  | -    | nC   | $V_{DD}=50\text{ V}$ , $I_D=6\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Switching charge                | $Q_{sw}$      | -      | 2.0  | -    | nC   | $V_{DD}=50\text{ V}$ , $I_D=6\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate charge total <sup>1)</sup> | $Q_g$         | -      | 6.8  | 9.1  | nC   | $V_{DD}=50\text{ V}$ , $I_D=6\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Gate plateau voltage            | $V_{plateau}$ | -      | 4.5  | -    | V    | $V_{DD}=50\text{ V}$ , $I_D=6\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$ |
| Output charge <sup>1)</sup>     | $Q_{oss}$     | -      | 9.0  | 12   | nC   | $V_{DD}=50\text{ V}$ , $V_{GS}=0\text{ V}$                                 |

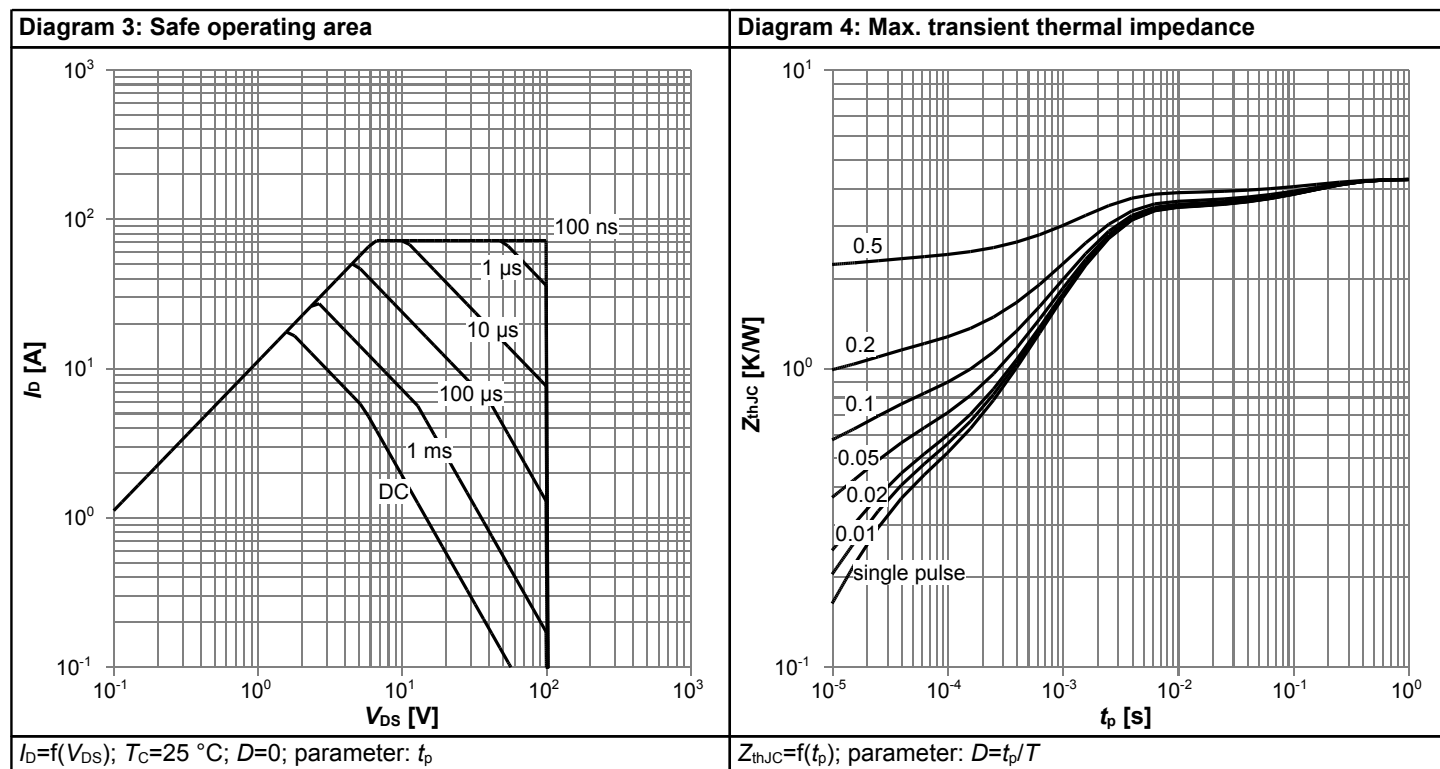
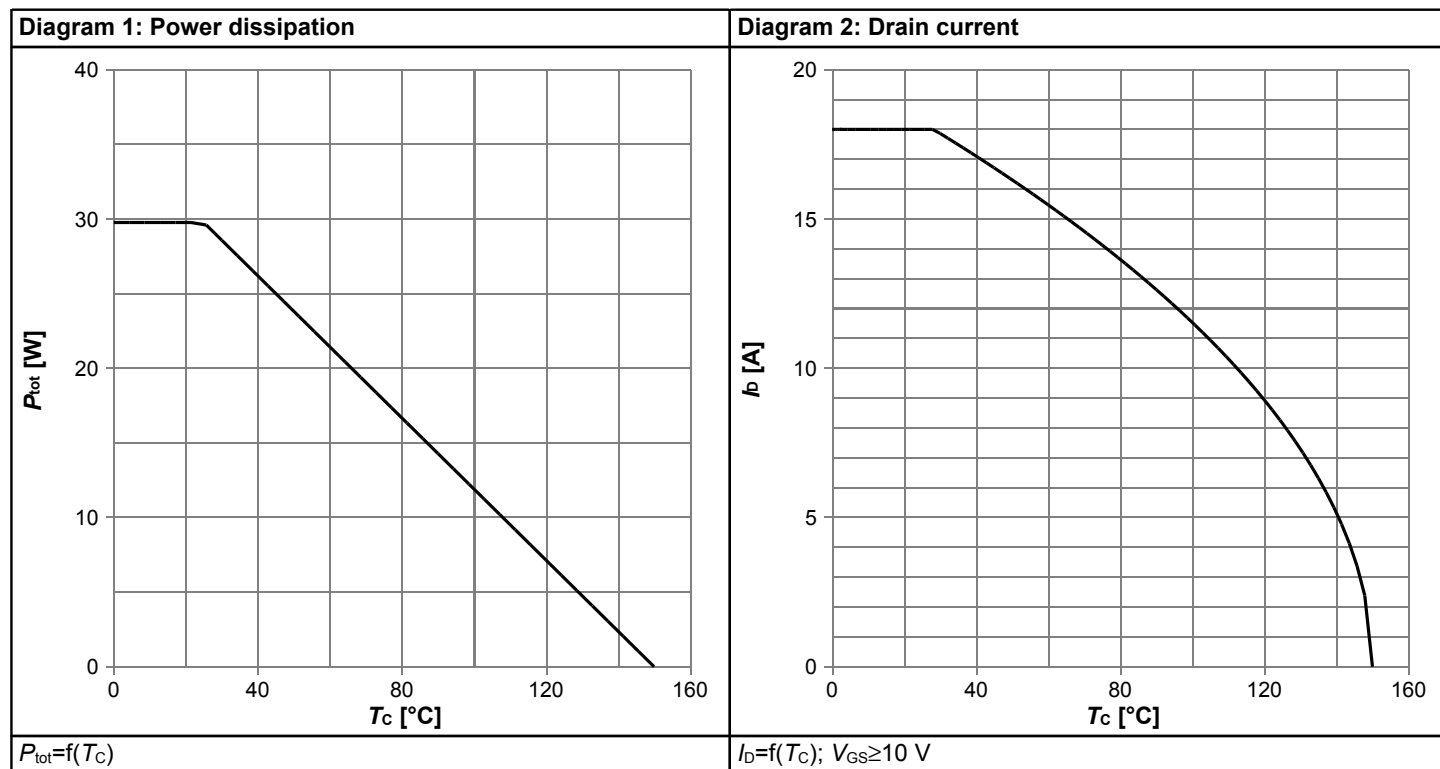
<sup>1)</sup> Defined by design. Not subject to production test.

<sup>2)</sup> See "Gate charge waveforms" for parameter definition

**Table 7 Reverse diode**

| Parameter                        | Symbol        | Values |      |      | Unit | Note / Test Condition                                                     |
|----------------------------------|---------------|--------|------|------|------|---------------------------------------------------------------------------|
|                                  |               | Min.   | Typ. | Max. |      |                                                                           |
| Diode continuous forward current | $I_S$         | -      | -    | 18   | A    | $T_C=25\text{ °C}$                                                        |
| Diode pulse current              | $I_{S,pulse}$ | -      | -    | 72   | A    | $T_C=25\text{ °C}$                                                        |
| Diode forward voltage            | $V_{SD}$      | -      | 1    | 1.2  | V    | $V_{GS}=0\text{ V}$ , $I_F=18\text{ A}$ , $T_J=25\text{ °C}$              |
| Reverse recovery time            | $t_{rr}$      | -      | 44   | -    | ns   | $V_R=50\text{ V}$ , $I_F=6\text{ A}$ , $di_F/dt=100\text{ A}/\mu\text{s}$ |
| Reverse recovery charge          | $Q_{rr}$      | -      | 61   | -    | nC   | $V_R=50\text{ V}$ , $I_F=6\text{ A}$ , $di_F/dt=100\text{ A}/\mu\text{s}$ |

## 5 Electrical characteristics diagrams



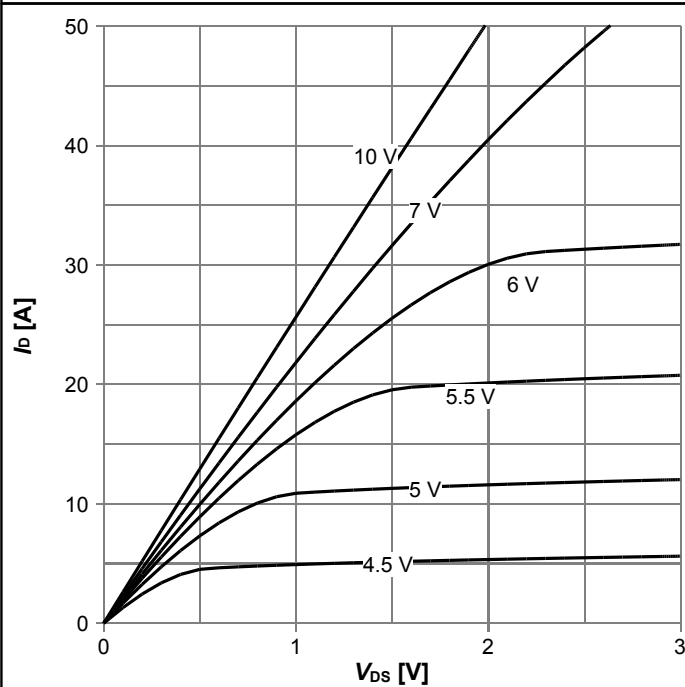
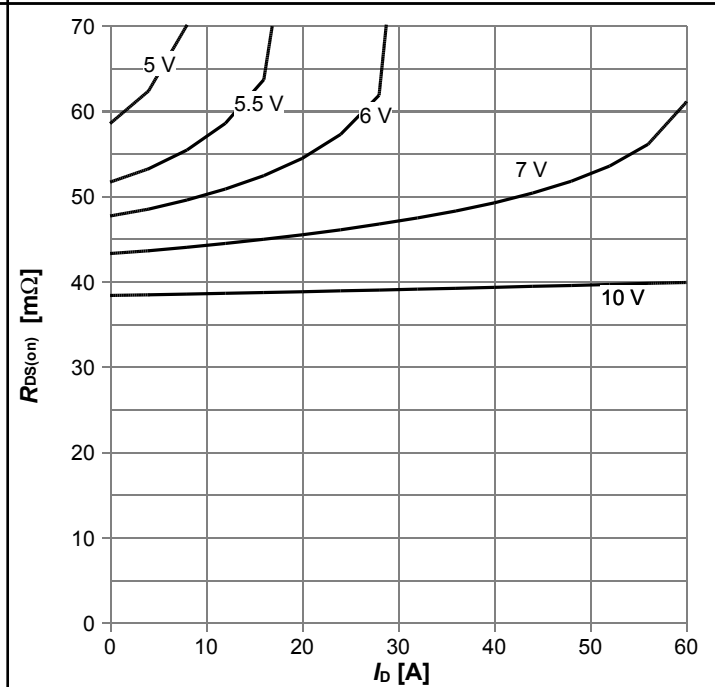
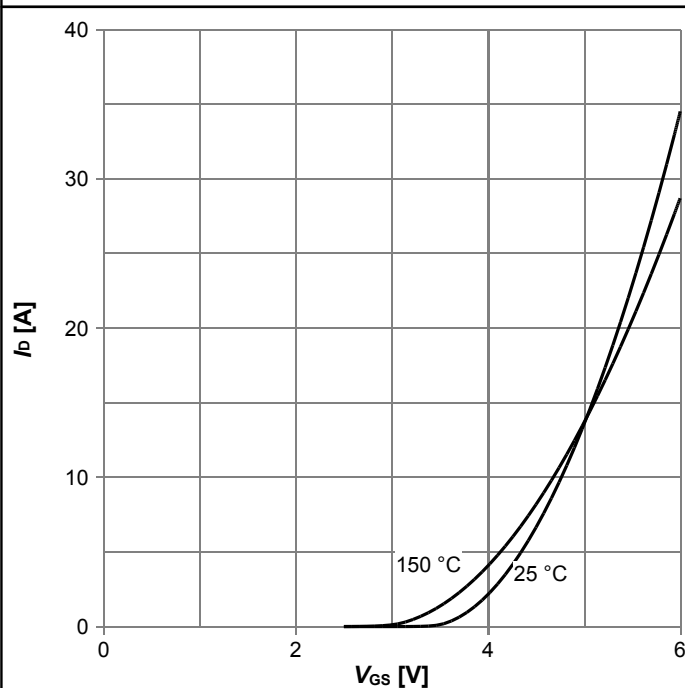
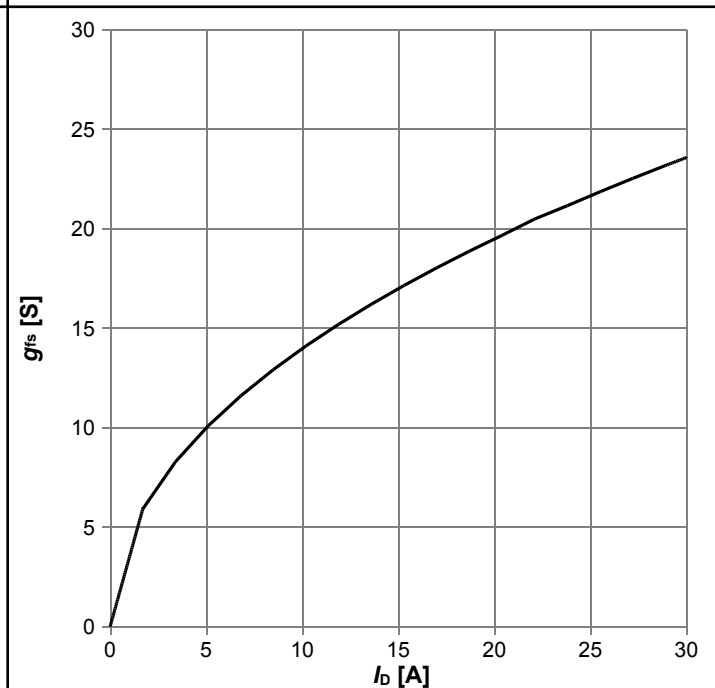
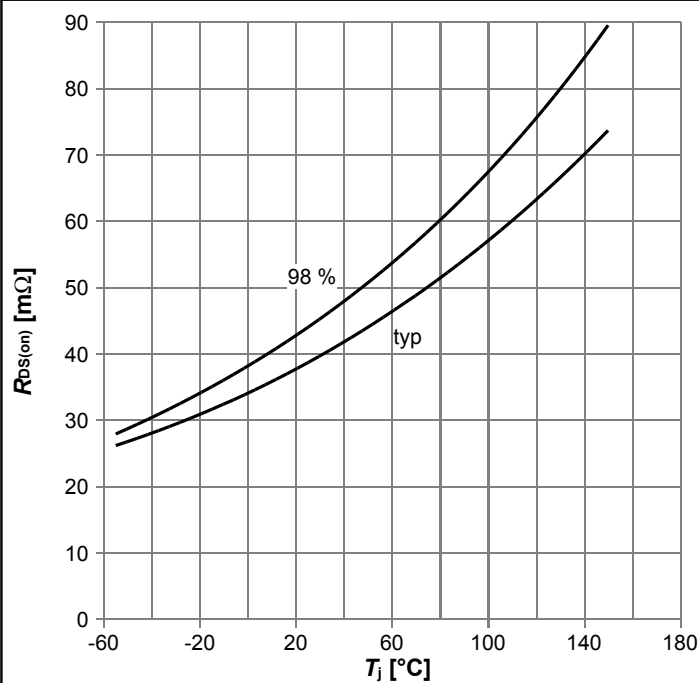
**Diagram 5: Typ. output characteristics**

 $I_D = f(V_{DS}); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$ 
**Diagram 6: Typ. drain-source on resistance**

 $R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$ 
**Diagram 7: Typ. transfer characteristics**

 $I_D = f(V_{GS}); |V_{DS}| > 2|I_D|R_{DS(on)\max}; \text{parameter: } T_j$ 
**Diagram 8: Typ. forward transconductance**

 $g_{fs} = f(I_D); T_j = 25^\circ\text{C}$

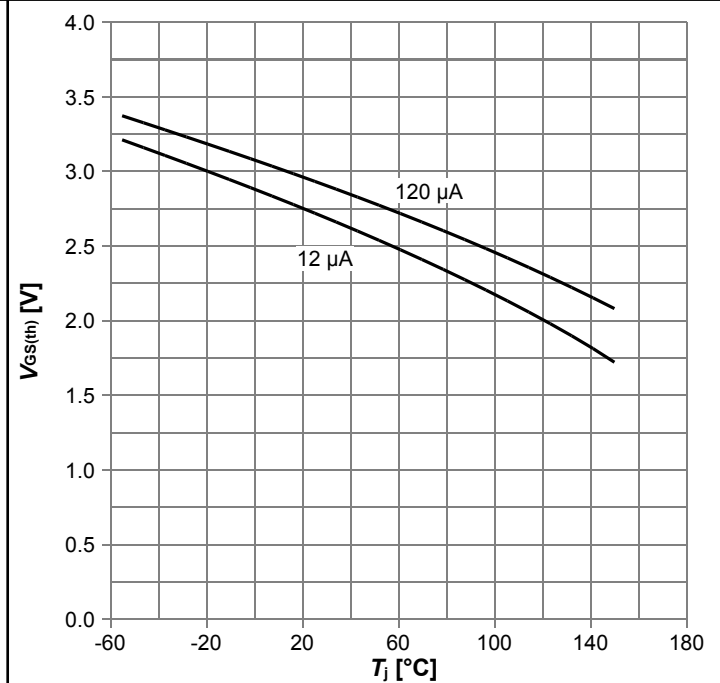


Diagram 9: Drain-source on-state resistance



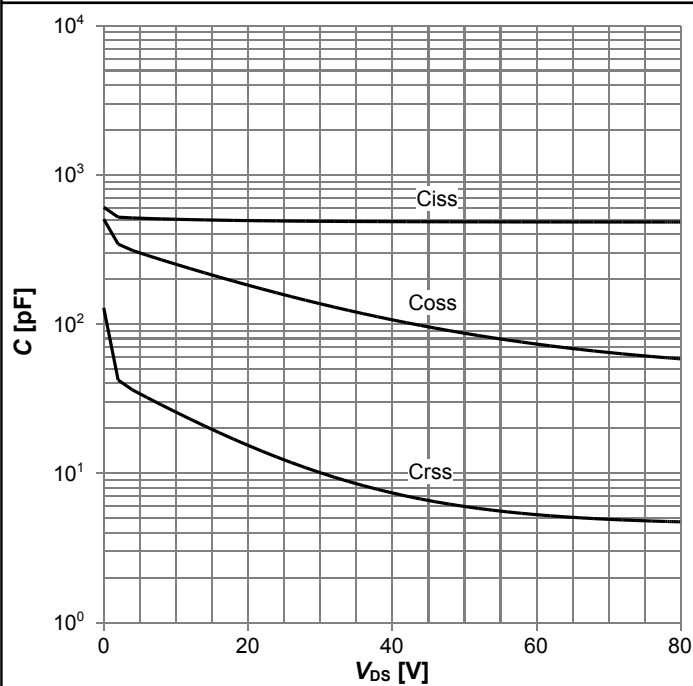
$$R_{DS(on)} = f(T_j); I_D = 12 \text{ A}; V_{GS} = 10 \text{ V}$$

Diagram 10: Typ. gate threshold voltage



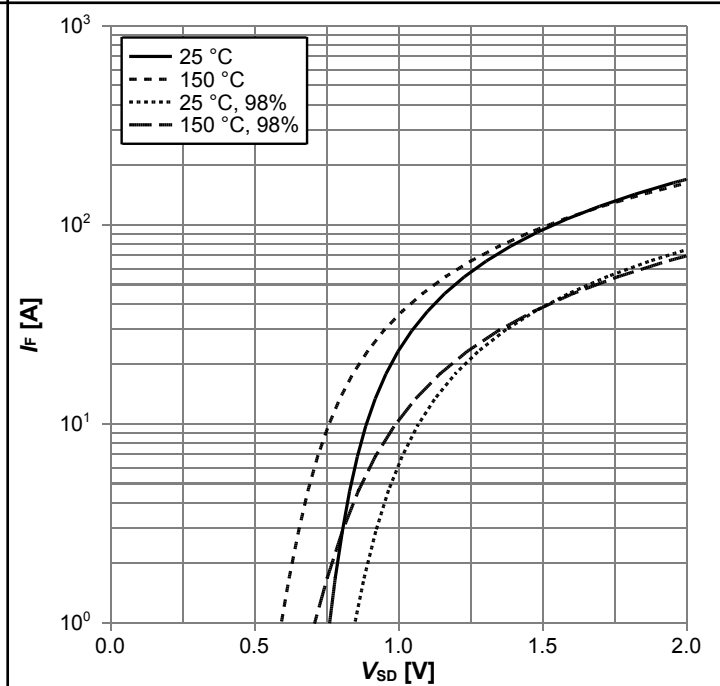
$$V_{GS(th)} = f(T_j); V_{GS} = V_{DS}; \text{parameter: } I_D$$

Diagram 11: Typ. capacitances



$$C = f(V_{DS}); V_{GS} = 0 \text{ V}; f = 1 \text{ MHz}$$

Diagram 12: Forward characteristics of reverse diode



$$I_F = f(V_{SD}); \text{parameter: } T_j$$

Diagram 13: Avalanche characteristics

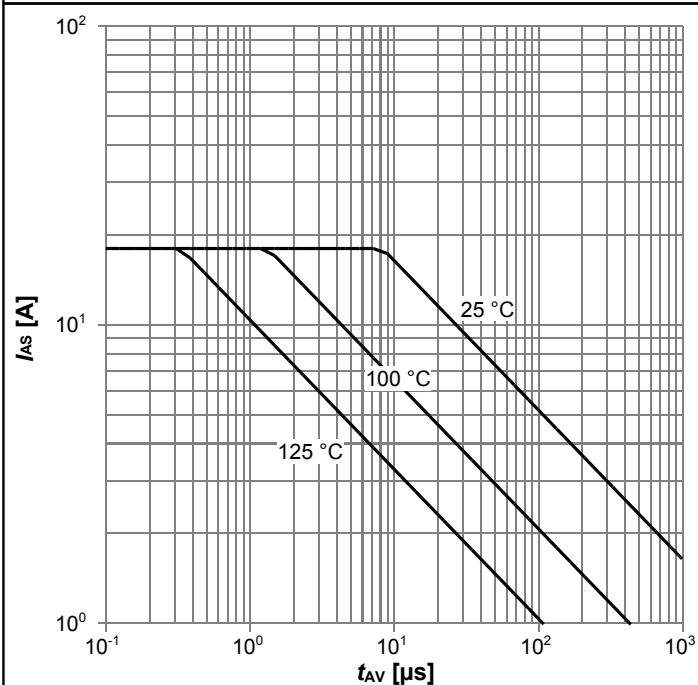

 $I_{AS}=f(t_{AV}); R_{GS}=25\ \Omega; \text{parameter: } T_{j(\text{start})}$ 

Diagram 14: Typ. gate charge

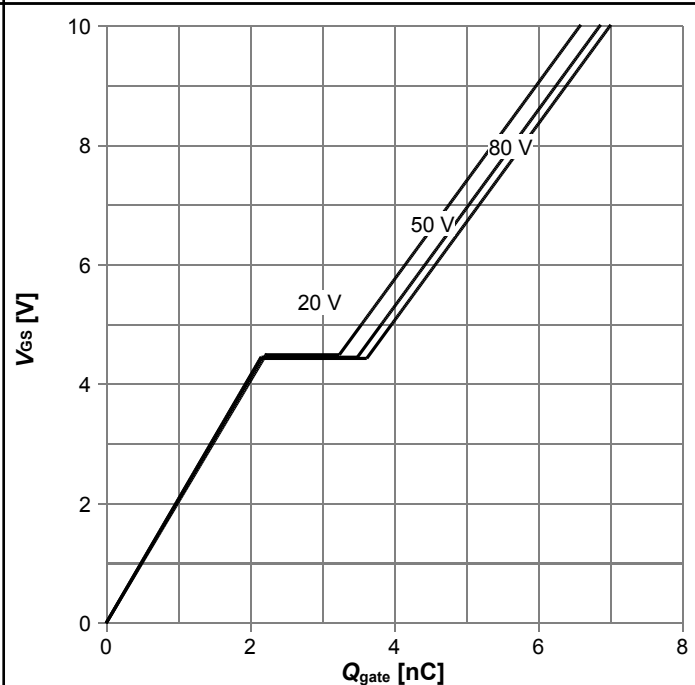
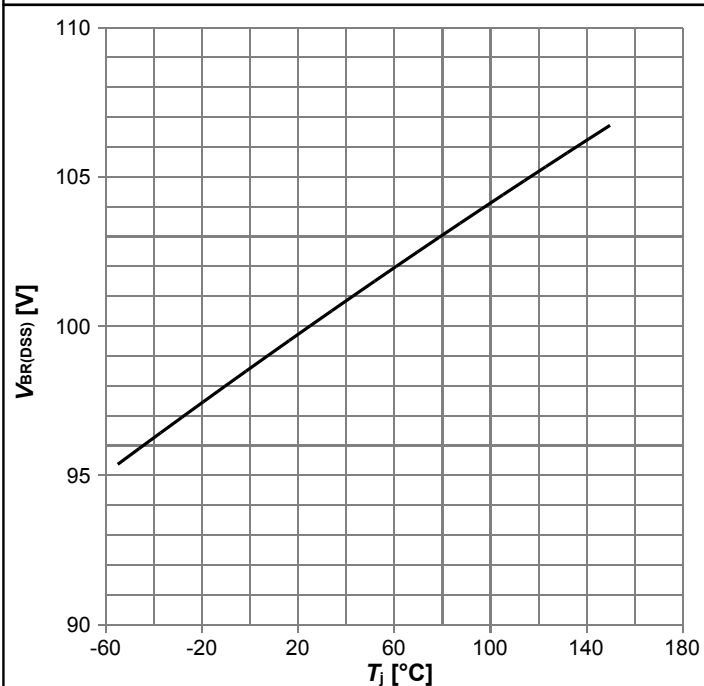
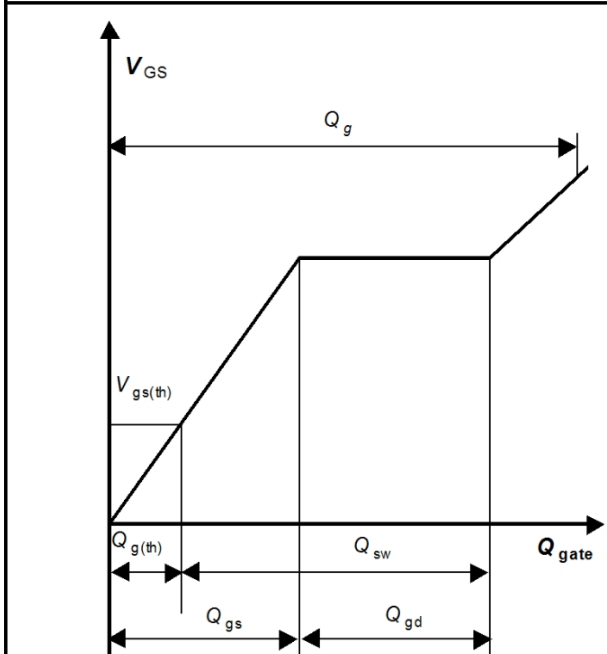

 $V_{GS}=f(Q_{\text{gate}}); I_D=6\ \text{A pulsed}; \text{parameter: } V_{DD}$ 

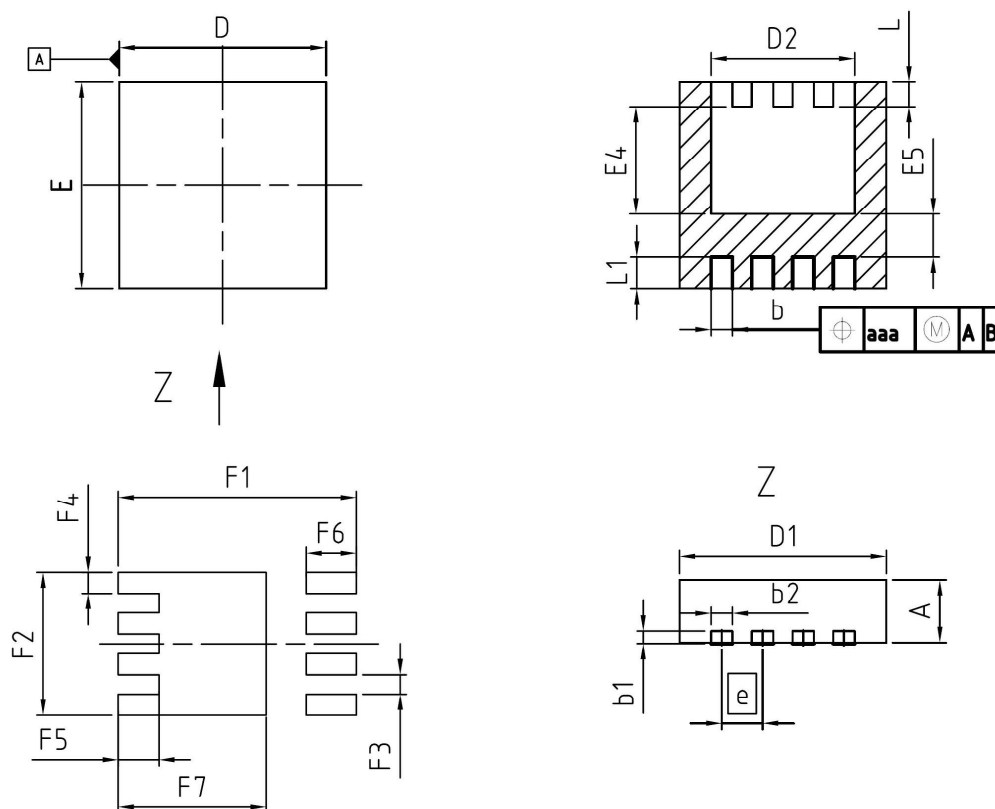
Diagram 15: Drain-source breakdown voltage


 $V_{BR(DSS)}=f(T_J); I_D=1\ \text{mA}$ 

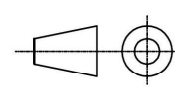
Gate charge waveforms



## 6 Package Outlines



| DIM  | MILLIMETERS |      | INCHES |       |
|------|-------------|------|--------|-------|
|      | MIN         | MAX  | MIN    | MAX   |
| A    | 0.90        | 1.10 | 0.035  | 0.043 |
| b    | 0.24        | 0.44 | 0.009  | 0.017 |
| b1   | 0.10        | 0.30 | 0.004  | 0.012 |
| b2   | 0.20        | 0.44 | 0.008  | 0.017 |
| D=D1 | 3.20        | 3.40 | 0.126  | 0.134 |
| D2   | 2.15        | 2.45 | 0.085  | 0.096 |
| E    | 3.20        | 3.40 | 0.126  | 0.134 |
| E4   | 1.60        | 1.81 | 0.063  | 0.071 |
| E5   | 0.59        | 0.86 | 0.023  | 0.034 |
| e    | 0.65        |      | 0.026  |       |
| N    | 8           |      | 8      |       |
| L    | 0.30        | 0.56 | 0.012  | 0.022 |
| L1   | 0.33        | 0.60 | 0.013  | 0.024 |
| aaa  | 0.25        |      | 0.010  |       |
| F1   | 3.80        |      | 0.150  |       |
| F2   | 2.29        |      | 0.090  |       |
| F3   | 0.31        |      | 0.012  |       |
| F4   | 0.34        |      | 0.013  |       |
| F5   | 0.65        |      | 0.026  |       |
| F6   | 0.80        |      | 0.031  |       |
| F7   | 2.36        |      | 0.093  |       |

|                                                                                                              |
|--------------------------------------------------------------------------------------------------------------|
| DOCUMENT NO.<br>Z8B00131645                                                                                  |
| SCALE<br>0 2.5 5mm                                                                                           |
| EUROPEAN PROJECTION<br> |
| ISSUE DATE<br>17-09-2008                                                                                     |
| REVISION<br>02                                                                                               |

**Figure 1 Outline PG-TSDSON-8, dimensions in mm/inches**

## Revision History

BSZ440N10NS3 G

**Revision: 2015-02-06, Rev. 2.1**

Previous Revision

| Revision | Date       | Subjects (major changes since last revision)               |
|----------|------------|------------------------------------------------------------|
| 2.1      | 2015-02-06 | Insert pin numbered package drawing and trr and Qrr values |

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